

**Notice of References Cited**

Application/Control No.

09/937,124

Applicant(s)/Patent Under  
Reexamination  
SEIDEL ET AL.

Examiner

Anthony J Kuhar

Art Unit

1754

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2,424,207	07-1947	C. Otto	423/550
	B	US-2,782,097	02-1957	J. J. Costolow	423/549
	C	US-2,805,125	09-1957	J. Van Ackeren	423/550
	D	US-2,827,366	03-1958	W.C. Saeman	422/252
	E	US-3,371,992	03-1968	Chung Yu Shen	423/268
	F	US-3,607,141	09-1971	Montagna et al.	23/301
	G	US-3,628,919	12-1971	Beauchamp et al.	23/301
	H	US-4,056,364	11-1977	Dmitrovsky et al.	422/253
	I	US-4,248,848	02-1981	Murakami et al.	423/474
	J	US-4,282,191	08-1981	Bird et al.	423/119
	K	US-4,305,913	12-1981	Anjier, Joseph L.	423/123
	L	US-4,568,527	02-1986	Anjier et al.	423/127
	M	US-4,657,559	04-1987	Mollere et al.	23/297

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 63103821 A	05-1988	Japan	OGAWA et al.	C01C 01/24
	O	JP 61286216 A	12-1986	Japan	WAKATSUKI et al.	C01C 01/24
	P	JP 01176214 A	07-1989	Japan	HORIBE et al.	C01C 01/24
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.